



LEADING PROVIDER OF ADVANCED SEMICONDUCTOR PACKAGING
AND TEST SERVICES FOR GLOBAL CUSTOMERS



High Density Packaging Needs for Next Generation Connected Markets

2018.05.31

A decorative graphic consisting of several light blue lines that originate from a solid blue rectangular block on the left side of the slide. These lines extend horizontally and then branch out into a series of parallel, slightly curved paths that resemble circuit traces or data lines, ending in small open circles on the right side of the slide.

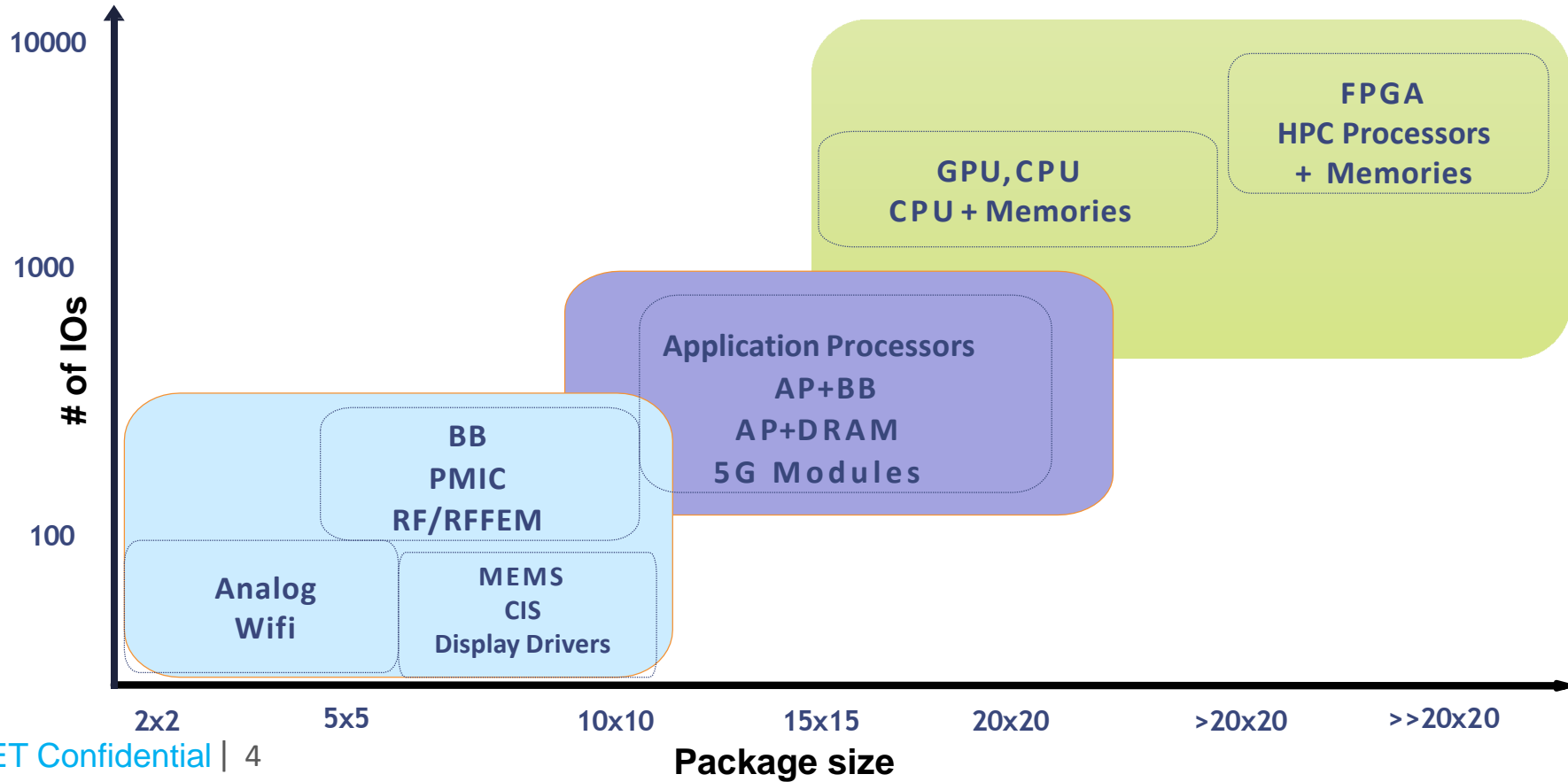
Urmi Ray



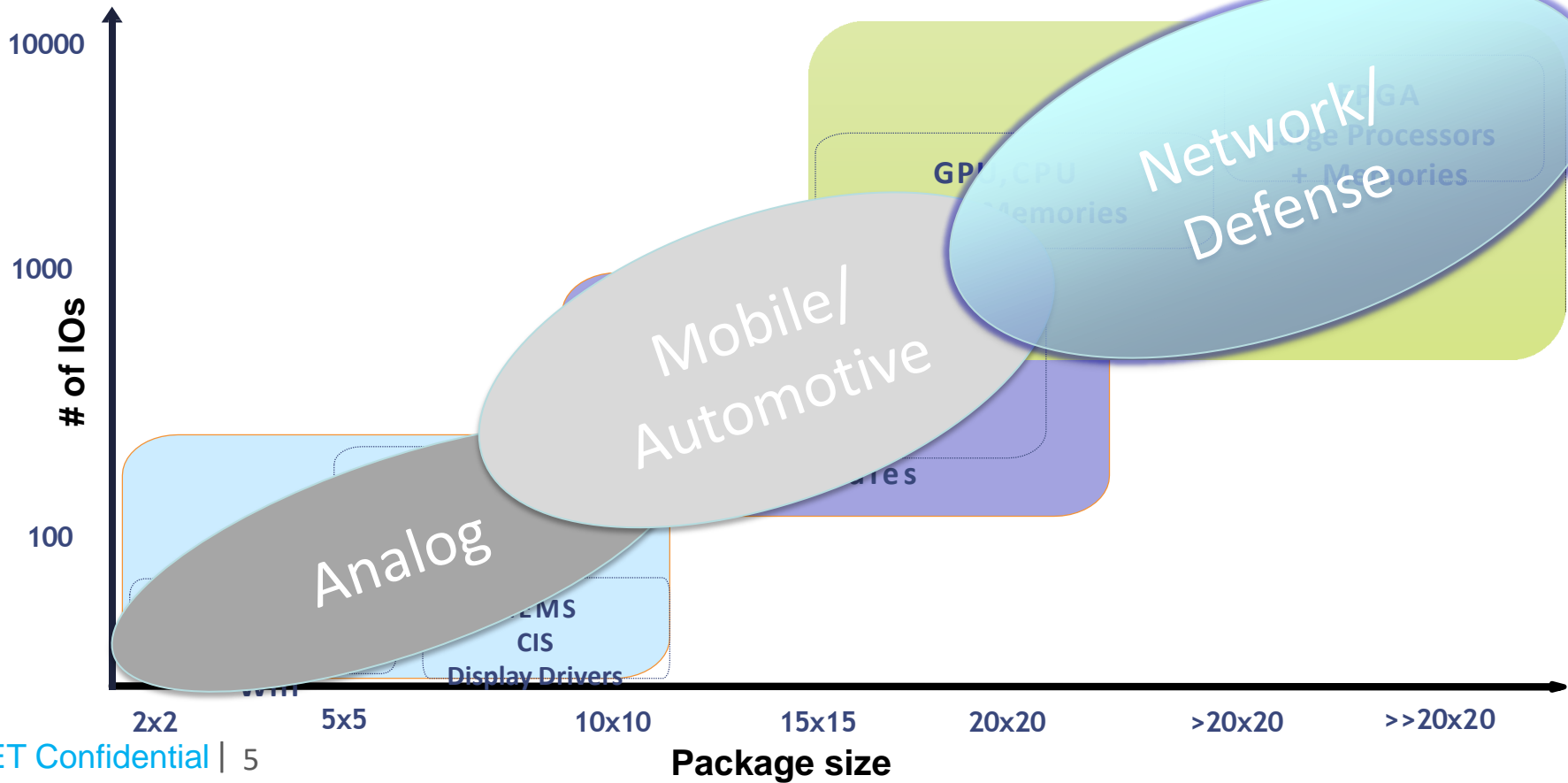
Contents

- Industry Advanced Packaging
 - System integration and COO optimization
- eWLB as high density packaging platform
- Conclusion

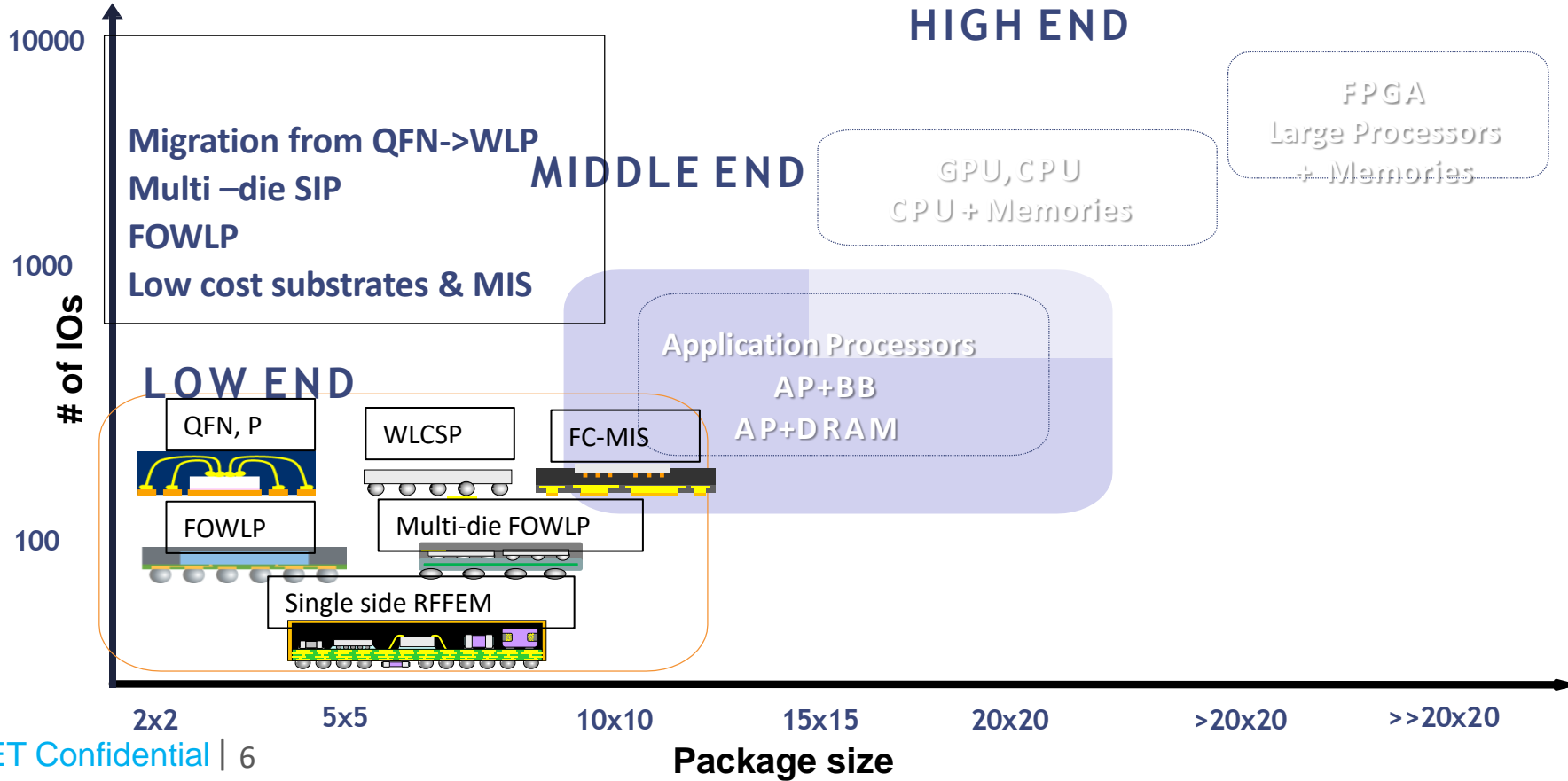
System Integration Trends (1/5)



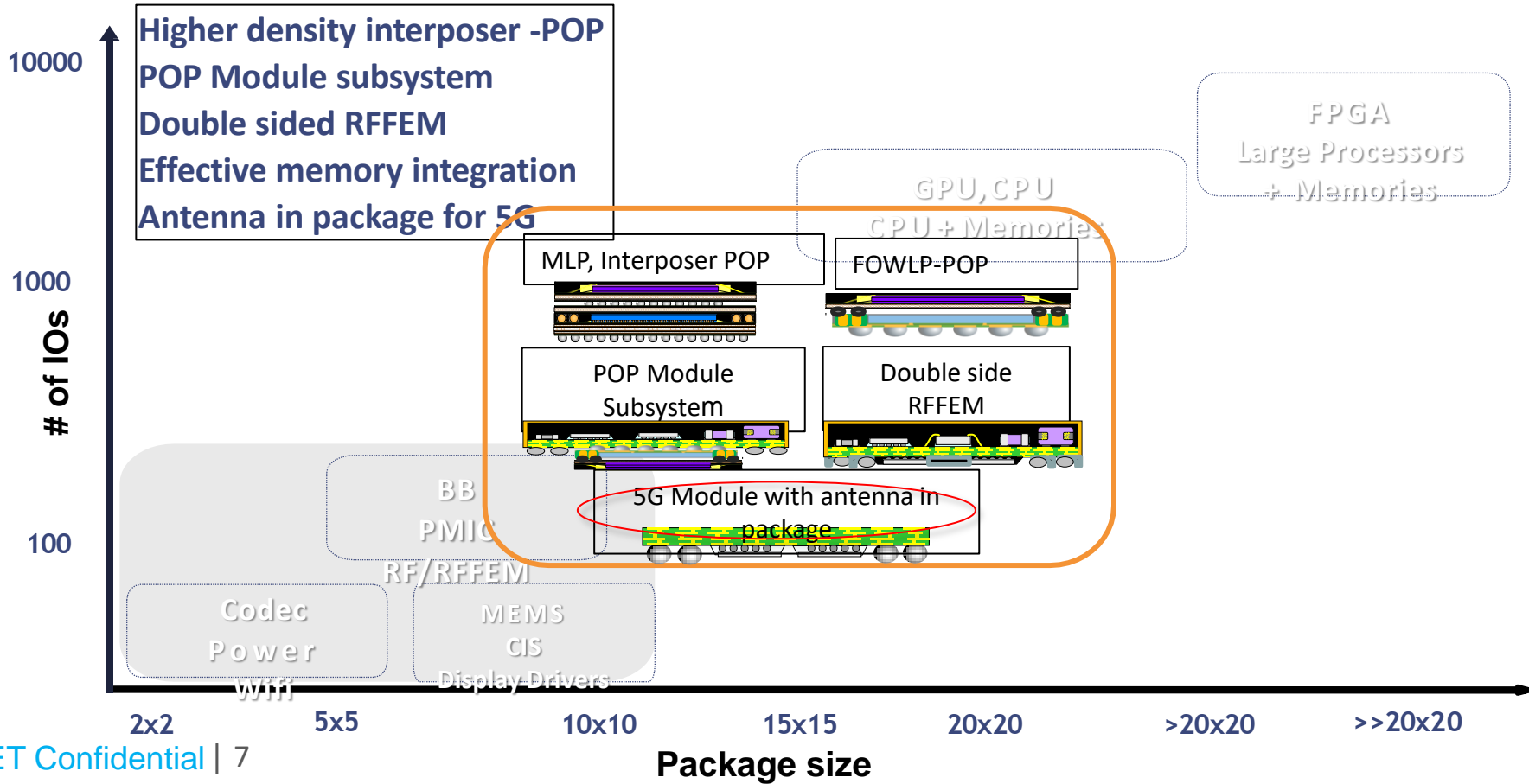
System Integration Trends (2/5)



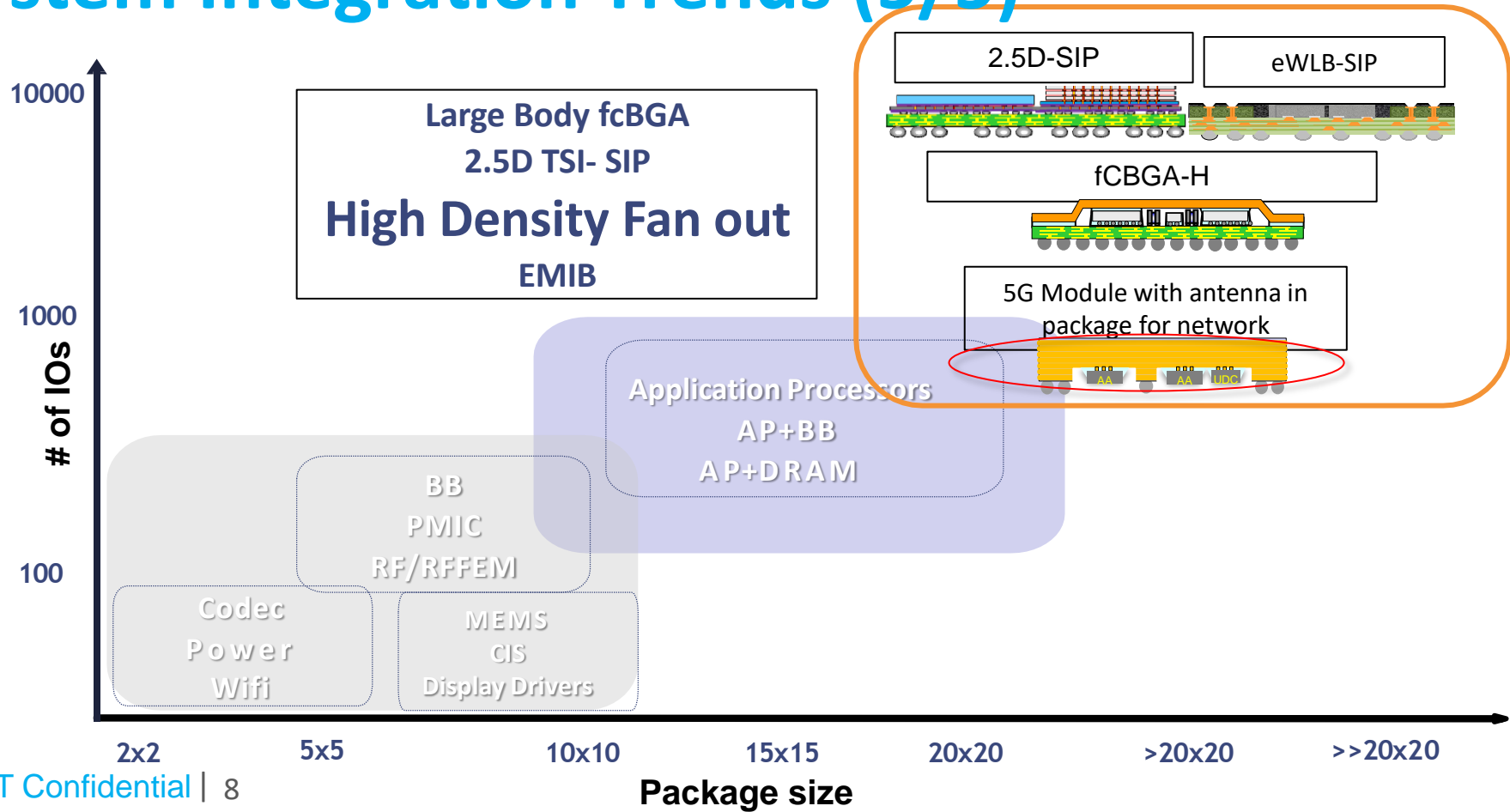
System Integration Trends (3/5)

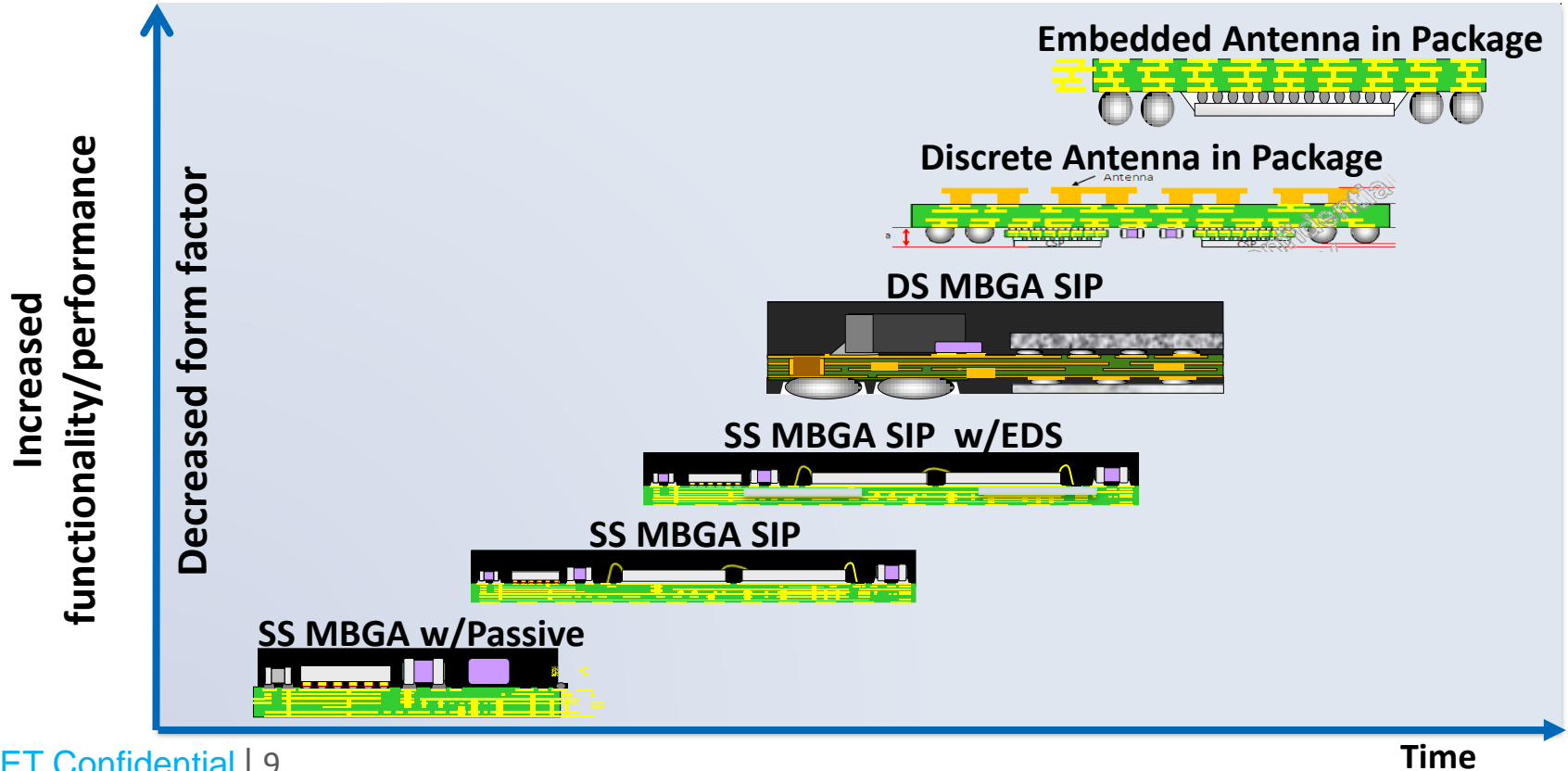


System Integration Trends (4/5)



System Integration Trends (5/5)



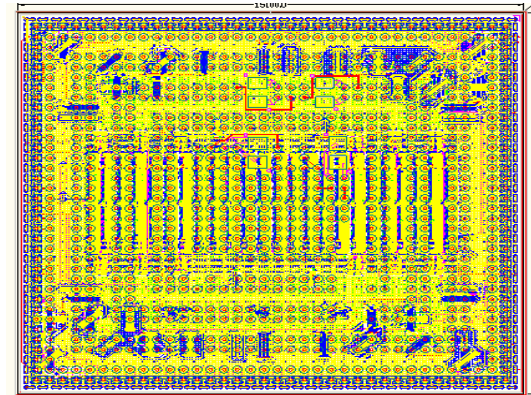
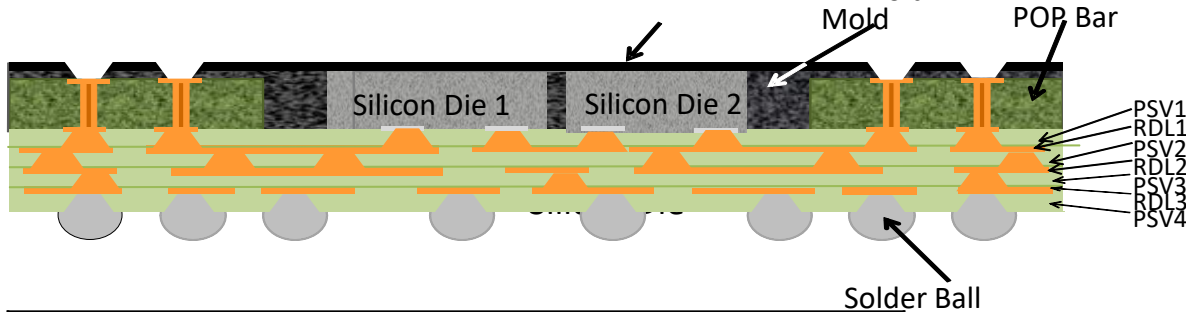


eWLB - high density packaging platform



High Density eWLB Package

eWLB and Fan out packages can serve as means of high density packaging
An Example is shown here



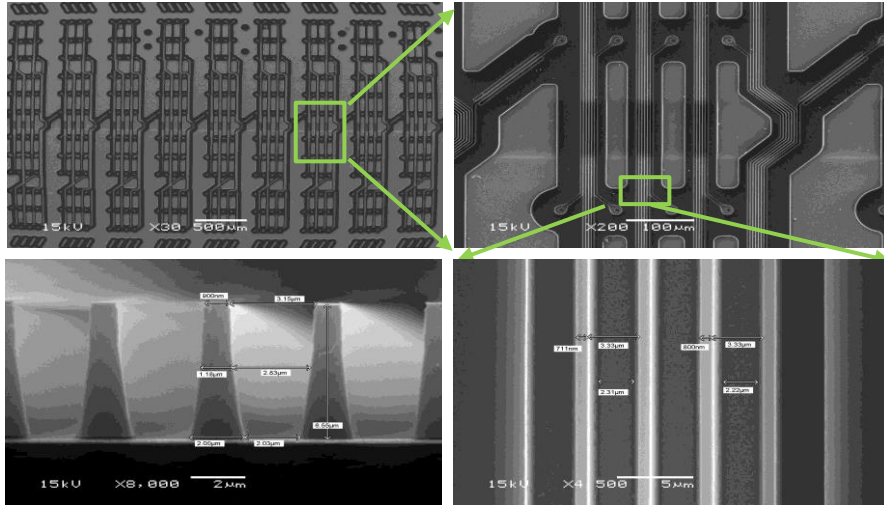
Package Configuration (3L RDL)	
Die Size	11.16 x 5.58 mm & 11.16 x 5.58 mm
PKG Size	15x15mm
Ball Composition	SAC305
Ball Pitch (Bottom / Top)	400um / 200um
Die Thickness (min)	200um
RDL Stack Thickness (nominal)	39um
Package ball height/size	185um
PKG Total Thickness (nominal)	424um

RDL Stack	39um+/-10um
PSV1	4um +/- 1.0um
RDL1	3um +/- 1.0um
PSV2	5um +/- 1.0um
RDL2	4um +/- 1.0um
PSV3	6um +/- 1.5um
RDL3	8um +/- 1.5um
PSV4	9um +/- 1.5um
Bump Height (SAC305)	185um

Fine Pitch RDL Development successfully completed

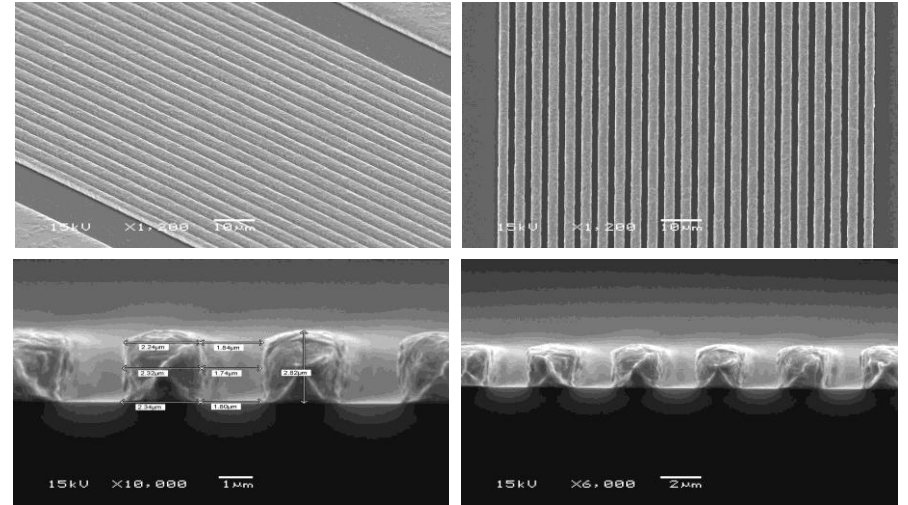
RDL1 Litho (2um L/S)

- BTM CD ~ 2.03um
- Sidewall Angle ~ 85°



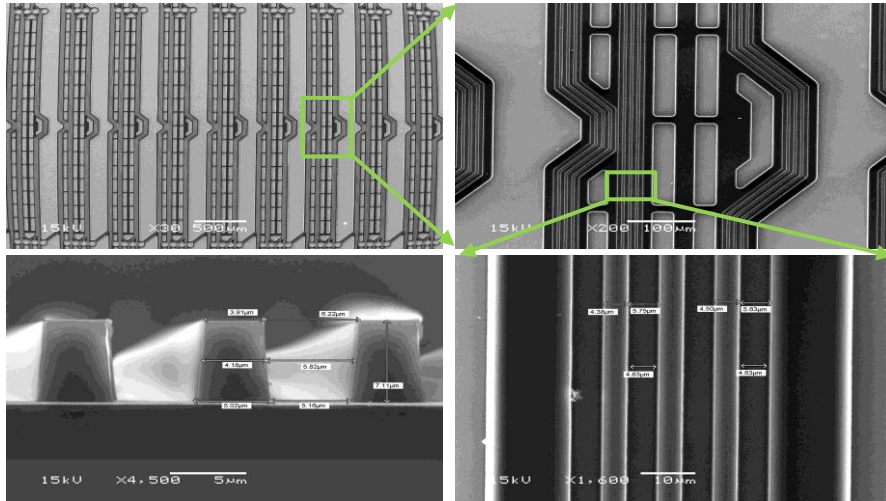
RDL1 after Plating/Etch

- RDL1 thickness ~ 2.82 um
- BTM CD ~ 2.34um
- Sidewall Angle $\geq 85^\circ$
- No undercut



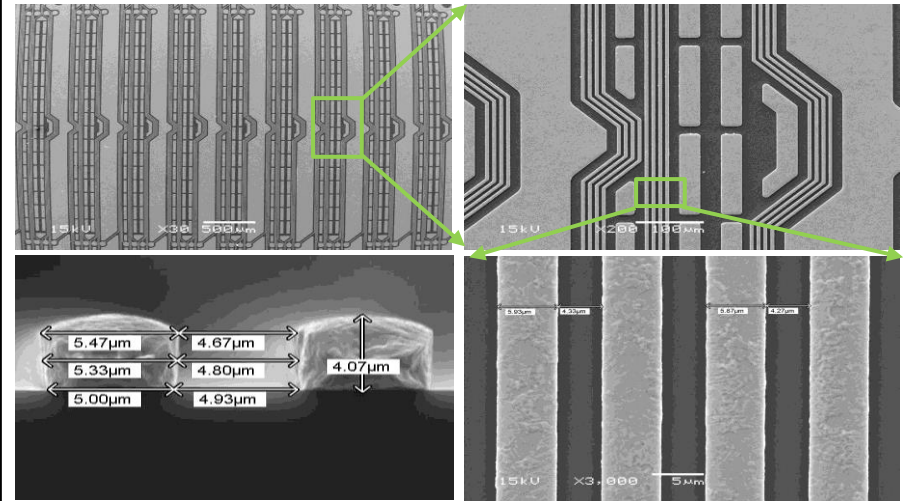
RDL2 Litho (5um L/S)

- BTM CD ~ 5.2um
- Sidewall Angle $\geq 85^\circ$

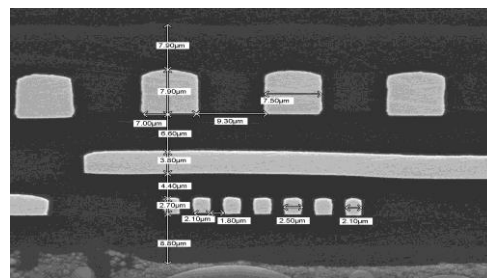
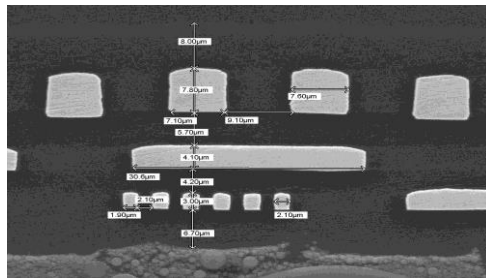
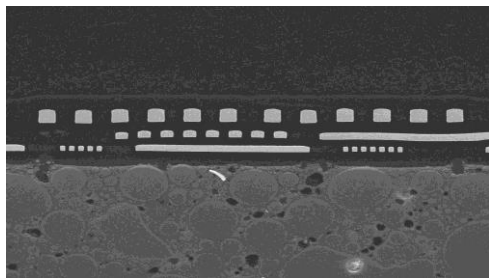


RDL2 after Plating/Etch

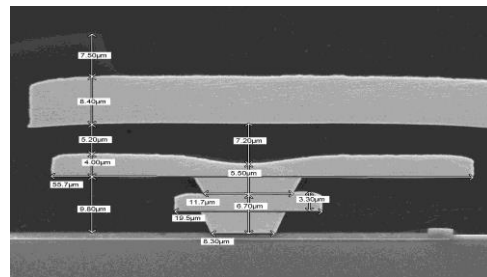
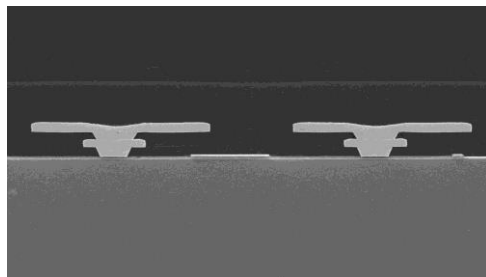
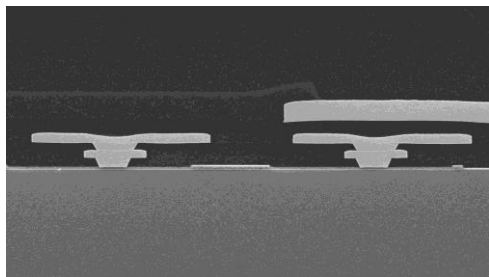
- RDL thickness ~ 4.1 um
- BTM CD ~ 5.0um
- Sidewall Angle $\geq 85^\circ$
- No undercut



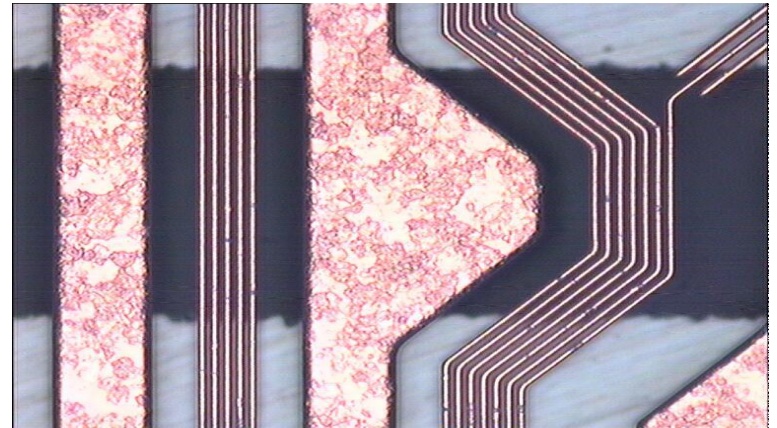
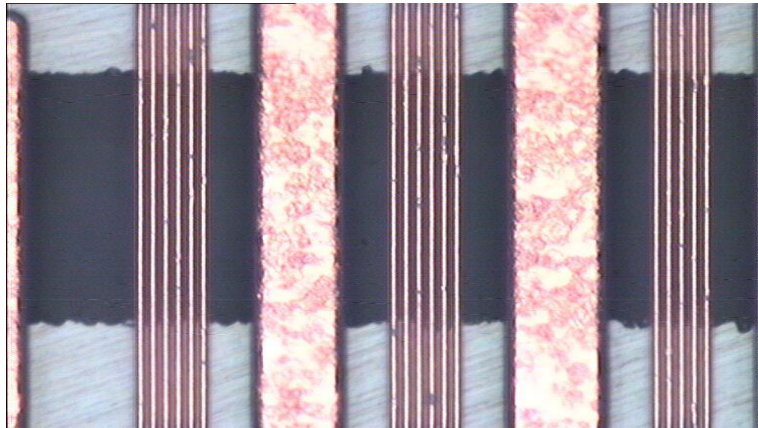
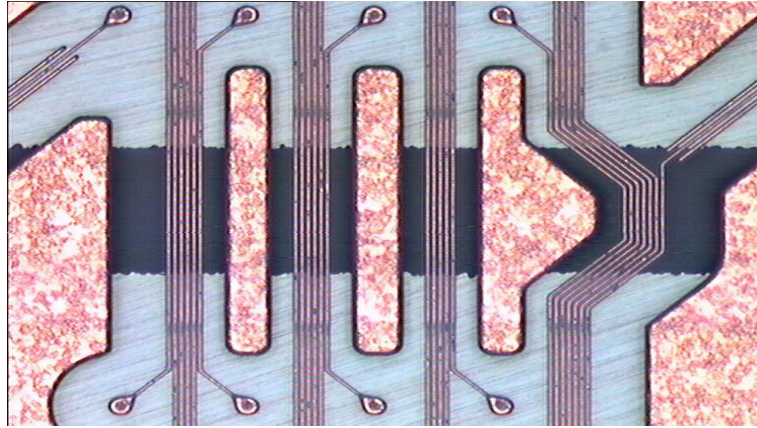
• 3L RDL Stack



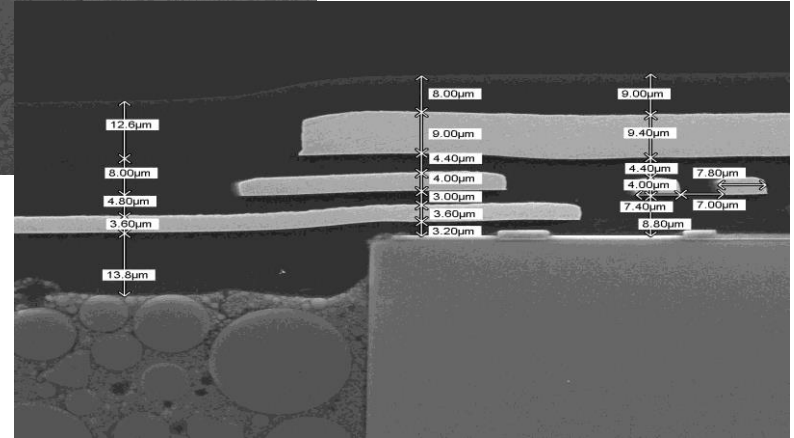
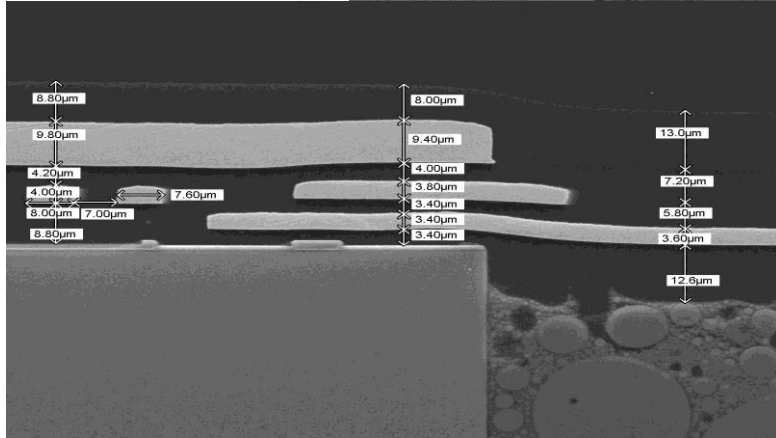
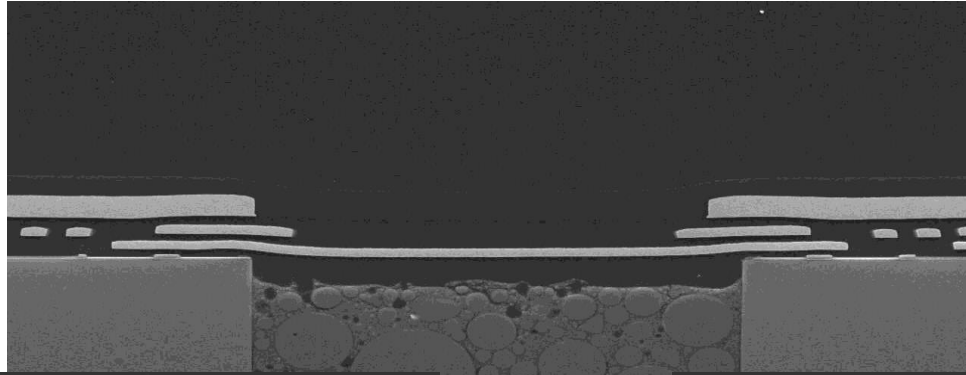
• Stacked Via



Technology: RDL 1 (2u L/S)



Technology: RDL1 Connection – between Die 1, Die 2 & JCET



Conclusion



Micro-Electronics Industry: Paradigm Changes

- Heterogeneous Integration is key enabler to solve the next decade's system challenges
- Diverse packaging solutions will provide customers with cost-effective solutions
- Successful product introductions will be facilitated by partnership and collaboration across supply chain partners:
 - OEMs/system houses
 - Design houses
 - Foundries/OSATs
 - Materials suppliers
 - Component vendors



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